High Current Ferrite Chip Inductor (Lead Free)

CPI201610HF -Series

1.Features

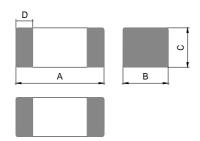
- 1. 2.0x1.6 mm and 1 mm in height (very compact size): CAE and fine printing technology made this compact size possible
- 2. Stable minimum DC resistance in the class.
- 3. High speed mounting: Using SMT mounter makes less than a second mounting possible.
- 4. Excellent mounting strength by SMD chip making.
- 5. Reduced noise over 2/3 of coil inductor by optimal design of CAD Completely lead-free product and support lead-free solder.







2. Dimensions



Chip Size						
Series	A(mm)	B(mm)	C(mm)	D(mm)		
201610	2.0±0.3	1.6±0.2	1.0 max	0.5±0.3		

3. Part Numbering



B: Dimension

C: Category Code

D: Material E: Inductance

F: Inductance Tolerance

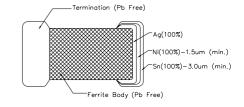
G: Rated Current

LxW

Lead Free Material

2R2=2.2uH M=±20%

1A2=1200mA



4. Specification

Tai-Tech	Inductance(uH)	Test Frequency	Rated Current	DCR	SRF
Part Number		(MHz)	(mA) max.	((MHz) min.
CPI201610HF-1R0M-1A3	1.0±20%	1	1300	0.12±30%	110
CPI201610HF-1R5M-1A3	1.5±20%	1	1300	0.12±30%	75
CPI201610HF-2R2M-1A2	2.2±20%	1	1200	0.14±30%	70
CPI201610HF-3R3M-1A0	3.3±20%	1	1000	0.18±30%	50
CPI201610HF-4R7M-0A9	4.7±20%	1	900	0.23±30%	40

5. Reliability and Test Condition

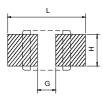
Item	Performano	Test Condition	
Operating Temperature	-40~+105 (Including self-		
Transportation Storage Temperature	-40~+105	For long storage conditions, please see the Application Notice	
Inductance (Ls)	Refer to standard electrical characteristics lis	Agilent4291 Agilent E4991 Agilent4287 Agilent16192	
DC Resistance Rated Current			Agilent 4338 DC Power Supply
Rated Current		Over Rated Current requirements, there will be some risk	
Temperature Rise Test	Rated Current < 1A ΔT 20 Max Rated Current 1A ΔT 40 Max		Applied the allowed DC current. Temperature measured by digital surface thermometer.
Solder heat Resistance		o mechanical damage. emaining terminal electrode:75% min.	Preheat: 150 , 60sec. Solder: Sn-Cu0.5 Solder temperature: 260±5 Flux for lead free: ROL0 Dip time: 10±0.5sec. Preheating Dipping Natural cooling 260°C 150°C 150°C 800
Solderability	More than 95% of the terminal electrode should be covered with solder.	Preheating Dipping Natural cooling 60 4±1 second	Preheat: 150 ,60sec. Solder: Sn-Cu0.5 Solder temperature: 245±5 Flux for lead free: ROL0 Dip time: 4±1sec.
Terminal strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions.	t W	Size Force (Kgf) Time(sec) 2016 0.6 >30
Flexture strength	The terminal electrode and the dielectric mus not be damaged by the forces applied on the right conditions.	Dending	Solder a chip on a test substrate, bend the substrate by 2mm (0.079in)and return. The duration of the applied forces shall be 60 (+ 5) Sec.
Bending Strength	The ferrite should not be damaged by Forces applied on the right condition.	0.5(0.02)	Size mm(inches) P-Kgf 2016 1.40(0.055) 1.0
Random Vibration Test	Appearance: Cracking, chipping and any other characteristics should not be allowed. Inductance: within±10%	er defects harmful to the	Frequency: 10-55-10Hz for 15 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 15 min This cycle shall be performed 12 times in each of three mutually perpendicular directions (Total 9hours).
Drop	a: No mechanical damage b: Inductance change: : within±10%		Drop 10 times on a concrete floor from a height of 75cm

Item	Perforn	Test Condition			
Life testing at High Temperature	Appearance: no damage.	Temperature: 105±2 Applied current: rated current. Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.			
Humidity	Inductance: within±10%of initial value.	Humidity: 90~95%RH. Temperature: 40±2 . Duration: 504±8hrs. Measured at room temperature after placifor 2 to 3hrs.			
Thermal shock	Appearance: no damage.	Phase	Temperature()	Time(min.)	Condition for 1 cycle Step1: -40±2 30±5 min. Step2: +105±2 30±5 min. Number of cycles: 500
	Inductance: within±10%of initial value.	2 3 Measured	-40±2 room temp. +105±2 d: 500 times	30±5 0.5 30±5	Measured at room temperature after placing for 2 to 3 hrs.
Low temperature storage test					Temperature: -40±2 . Duration: 500±8hrs. Measured at room temperature after placing for 2 to 3hrs.

6. Soldering and Mounting

6-1. Recommended PC Board Pattern

Chip Size							Pattern ow Sold	
Serie	Туре	A(mm)	B(mm)	C(mm)	D(mm)	L(mm)	G(mm)	H(mm)
CPI	201610	2.0±0.3	1.6±0.20	1.0 max	0.5±0.30	3.00	1.00	1.60



PC board should be designed so that products can prevent damage from mechanical stress when warping the board.

Products shall be positioned in the sideway direction against the mechanical stress to prevent failure.

6-2. Soldering

Mildly activated rosin fluxes are preferred. The terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools. Note.

If wave soldering is used ,there will be some risk.

Re-flow soldering temperatures below 240 degrees, there will be non-wetting risk

6-2.1 Lead Free Solder re-flow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1.

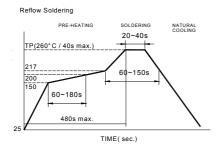
6-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. for Iron Soldering in Figure 2.

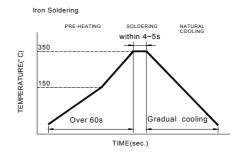
Preheat circuit and products to 150 350 tip temperature (max)

Never contact the ceramic with the iron tip 1.0mm tip diameter (max)

Use a 20 watt soldering iron with tip diameter of 1.0mm Limit soldering time to 4~5sec.



Reflow times: 3 times max Fig.1



Iron Soldering times: 1 times max Fig.2

6-2.3 Solder Volume:

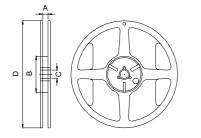
Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:

Minimum fillet height = soldering thickness + 25% product height



7. Packaging Information

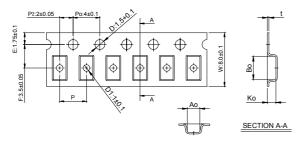
7-1. Reel Dimension





Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9±0.5	60±2	13.5±0.5	178±2

7-2 Tape Dimension / 8mm

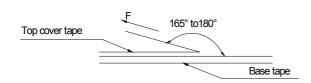


Size	P(mm)	Bo(mm)	Ao(mm)	Ko(mm)	t(mm)
201610	4.0±0.1	2.40±0.20	1.95±0.15	1.45max.	0.30max.

7-3. Packaging Quantity

Chip size	201610
Reel	3000
Inner box	15000
Middle box	75000
Carton	150000

7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp.	Room Humidity	Room atm	Tearing Speed	
()	(%)	(hPa)	mm/min	
5~35	45~85	860~1060	300	

Application Notice

Storage Conditions

To maintain the solder ability of terminal electrodes:

- 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: -10~ 40 and 30~70% RH.
- 3. Recommended products should be used within 6 months from the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.

Transportation

- 1.Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

Typical Inductance v.s. Frequency Curve

